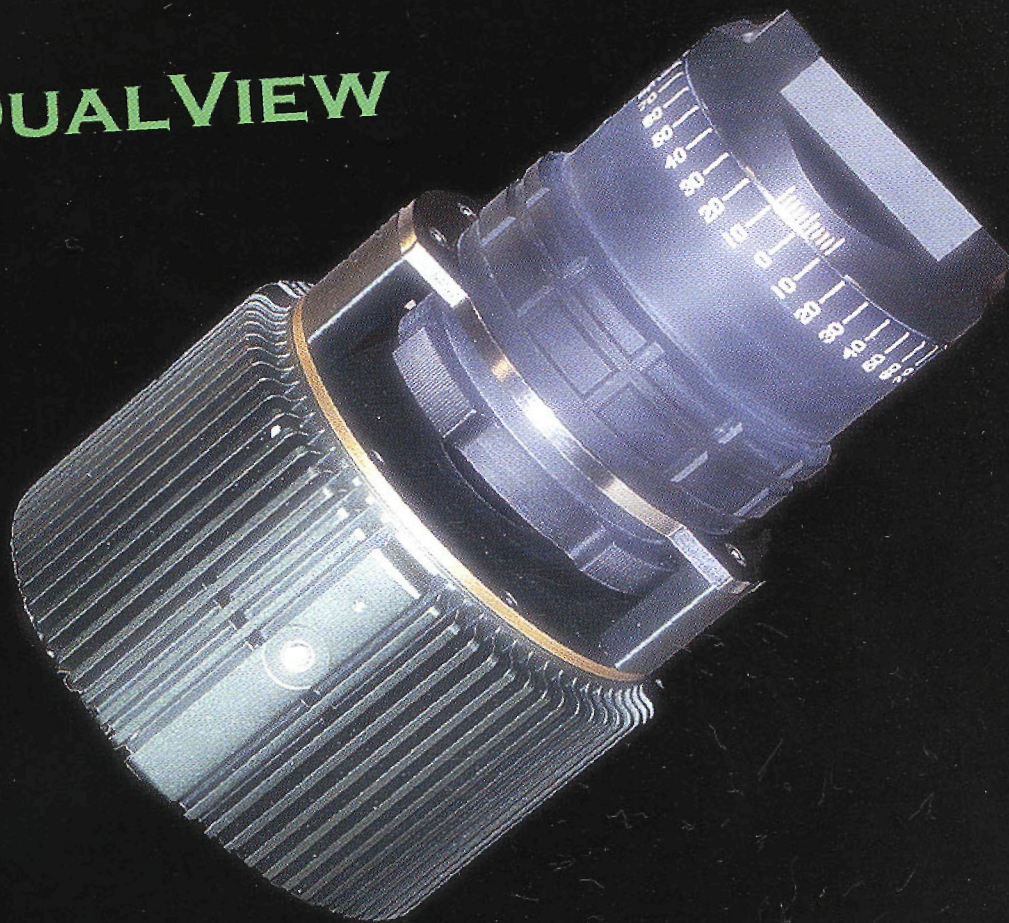


Digital technology is changing the way we look at the world.

Upgrade your existing TEM to obtain **high resolution digital images** and **digital movies**. **DualView** adds a new dimension for the material science or bioscience field. Isn't it time you made the move to digital?

DUALVIEW



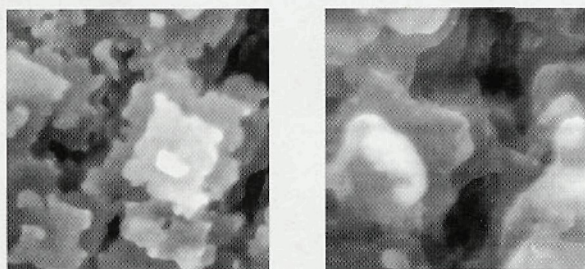
are you digital yet



Digital Integrity

www.gatan.com

As Easy As It Looks



PEO at 60°C with evidence of melting clearly shown after 2 minutes.

- ▶ **Based on a Simple PC Interface.**
- ▶ **Intuitive Operation with a Mouse Alone.**
- ▶ **Capable of Imaging Under Either Ambient or High Vacuum and at Both High and Low Temperatures.**
- ▶ **Fully Vibrationally Isolated.**
- ▶ **Capable of Wet or Dry Imaging.**
- ▶ **Variable Gas Pressure/Temperature.**

The new JSPM-4200 is a multipurpose turnkey Scanning Probe Microscope (SPM) capable of imaging using a myriad of different modes and

NEW - Multi-Environmental

SPM

Scanning Probe Microscope

accessories. Imaging modes include STM, STS (Scanning Tunneling Spectroscopy), CITS (Current Imaging Tunneling Microscopy), AFM, LFM (Lateral Force Microscopy), Non-contact Mode AFM, Discrete Contact Mode AFM, Lateral Modulation LFM, MFM (Magnetic Force Microscopy), and Force Modulation Microscopy.

If you would like to learn more about JEOL SPM's please give us a call and arrange for your own hands-on demonstration so that we can prove to you that it really is "As Easy As It looks".

JEOL USA, Inc., 11 Dearborn Road, Peabody, MA 01960
Tel: 978/535-5900 • Fax: 978/536-2205
Email: spm@jeol.com • WEB: <http://www.jeol.com>

JEOL